

Application No.	Applicant(s)	
09/840,860	ITO ET AL.	
Examiner	Art Unit	
Marc R Filipczyk	2161	

SEARCHED				
Class	Subclass	Date	Examiner	
707	10, 100, 101, 200, 203-206	2/28/2005	MF	
Update	search	2/28/2005	MF	
705	1	2/28/2005	MF	
update	search	3/1/2005	MF	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		-		

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
metadata, schema, database, dimensions, measures, table, cube, OLAP, map, link, consulted with Frantz Coby (2161)	2/28/2005	MF
EAST/ IEEE; fact table, model, metadatabase, analyze; consulted F. Poinvil (3628)	2/28/2005	MF
CiteSeer; metadata managing, schema, database	3/1/2005	MF
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